



USB 2.0 Hi-Speed Embedded Host Compliance Test Report

USB-IF Compliance Program			
Company Name	Microsemi, SOC Products Group		
Product Name	Smartfusion2 EH		
Model Number	DVP-102-000304-001-RevC		
Product Revision	1		
Test Date	September 23 ~ 24, 2013		
Test Result	PASS		

A. Vendor and Product Information

Vendor Information	
■ Vendor Name: Microsemi, SOC Products Group	
■ Vendor Complete Address: <u>3850 North First Street, SanJose, CA, 9513</u>	34, <u>USA</u>
■ Vendor Phone Number: <u>8007134113</u>	
■ Vendor Contact(s) – Name: Wendy Lockhart	
Tel: <u>8007134113</u>	
E-mail: xx	
Product Information	
■ Silicon Model Name: SMSC, USB3326C	
■ TID(if you know): 120000265 VID: 0x1514 PID: 1	n/a
■ Product Category: Development-Embedded Host-High Speed	Į.
■ Product Description: Silicon Building Block	
Comments:	
■ Tested OS: Windows 2000 Windows XP Embedded OS	
Device Information	
■ Number of downstream ports:	+
■ Supported Sessions:	\square ADP \square SRP \boxtimes N/A
■ USB Connector:	☐ Micro AB ☐ Standard A
■ Is there a hub embedded behind one or more downstream ports?	No
■ What is the maximum source current rating of the downstream ports?	500 mA
■ Are hubs supported?	No
■ Is there an upstream port on the Device?	No
■ Is a Targeted Peripheral List available?	Yes
■ FS supported?	No
■ Battery Charging 1.2 supported?	No
	Tastad Ry Loonsi Lung

Overall Test Result: PASS

B. Legacy USB Electrical Tests

B.1 Drop/Droop Test Results: 🖂 Pass 🔲 Fail on Port:			_ N/A	
	V _{Non-Loaded} (V)	$V_{Loaded}(V)$	$V_{Drop}(mV)$	$V_{Droop}(mV)$
Port1	5.160	4.900	260	N/A

Comments: 500 mA Load

B.2 Full-Speed Downstream Signal	Quality Test Result:
□ Pass □ Fail on Port:	□ N/A
<u>Comments:</u>	
B.3 Low-Speed Downstream Signal	Quality Test Result:
☐ Pass ☐ Fail on Port:	⊠ N/A
Comments:	



C. Host High-Speed Electrical Tests

C.1 Ho	ost High-speed	Signal Quality (EL_2, EL_3,	EL_6, EL_7)			
EL_2	A USB 2.0 high-speed transmitter data rate must be 480 Mb/s \pm 0.05%.					
	Reference documents: USB 2.0 Specification, Section 7.1.11					
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_3	A USB 2.0 down		ate 1 transform waveform requirements measured at TP2			
(cach ha	-	nents: USB 2.0 Specification, Section	n 7.1.2.2			
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_6	A USB 2.0 HS dr	iver must have 10% to 90% differen	tial rise and fall times of greater than 500ps.			
	Reference docum	nents: USB 2.0 Specification, Section	n 7.1.2.2			
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_7	A USB 2.0 HS	driver must have monotonic data	transitions over the vertical openings specified in the			
appropri	ate eye pattern tem	plate.				
	Reference docum	nents: USB 2.0 Specification, Section	n 7.1.2.2			
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
С.2 Но	ost Controller F	Packet Parameters (EL_21, E	L_22, EL_23, EL_25, EL_55)			
EL_21	The SYNC filed	for all transmitted packets (not repea	ted packets) must begin with a 32-bit SYNC field.			
	Results: 66.905 n	nents: USB 2.0 Specification, Sections	n 8.2			
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_25	The EOP for all	transmitted packets (except SOFs)	must be an 8-bit NRZ byte of 01111111 without bit			
stuffing.	(Note, that a longe	er EOP is waiverable)				
	Reference docur	ments: USB 2.0 Specification, Section	n 7.1.13.2			



Page: 5/13

	Results: <u>16.857</u>	ns	
	⊠ Pass	Fail on Port:	□ N/A
	Comments:		
EL_23 than 192	Host transmitting bit times.	g two packets in a row must have an	n inter-packet gap of at least 88 bit times and not more
	Reference docu	ments: USB 2.0 Specification, Section	n 7.1.18.2
	Results: <u>333.307</u>	<u>7</u> ns	
	⊠ Pass	Fail on Port:	□ N/A
	Comments:		
EL_22	When transmitti		I devices must provide an inter-packet gap of a t least 8
on times		ments: USB 2.0 Specification, Section	n 7.1.18.2
	Results: 278.154		
	⊠ Pass	Fail on Port:	□ N/A
	Comments:		
EL 55	Hosts transmittii	ng SOF packets must provide a 40-bi	t EOP without bit stuffing where the first symbol of the
_		ne last data symbol.	
	Reference docu	ments: USB 2.0 Specification, Section	n 7.1.13.2
	Results: <u>83.549</u>	ns	
	⊠ Pass	Fail on Port:	□ N/A
	Comments:		
С.3 Но	st Disconnect	Detect (EL_36, EL_37)	
EL_37	A USB 2.0 down	nstream facing port must not detect th	e high-speed disconnect state when the amplitude of the
different	_	ownstream facing driver's connector is	
	Reference docu	ments: USB 2.0 Specification, Section	n 7.1.7.3
	Pass	Fail on Port:	⊠ N/A
	Comments:		
EL_36			high-speed disconnect state when the amplitude of the
different	_	ownstream facing driver's connector is	
	Reference docu	ments: USB 2.0 Specification, Section	n 7.1.7.3

	☐ Pass	Fail on Port:	⊠ N/A			
	Comments:					
С.4 Но	ost CHIRP Tim	ing (EL_33, EL_34, EL_35)				
EL_33			e of Chirp K's and Chirp J's within 100us after the			
device C	Chirp K stops.					
	Reference docum	nents: USB 2.0 Specification, Section 7.	1.7.5			
	Results: <u>2.259</u> us					
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_34	Downstream port	Chirp K and Chirp J durations must be l	between 40us and 60us duration.			
	Reference documents: USB 2.0 Specification, Section 7.1.7.5					
	Results: <u>50.017/5</u>	<u>0.013</u> us				
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_35 Chirp (J	_	s begin sending SOFs within 500us and	not sooner than 100us from transmission of the last			
	Reference docun	nents: USB 2.0 Specification, Section 7.	1.7.5			
	Results: <u>225.230</u>	us				
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
С.5 Но	ost Suspend/Res	sume Timing (EL_39, EL_41)				
EL_39	A device must support the Suspend state.					
	Reference documents: USB 2.0 Specification, Section 7.1.7.6					
	Results: <u>3.005</u> ms					
	⊠ Pass	Fail on Port:	□ N/A			
	Comments:					
EL_41	After resuming a	port, the host must begin sending SOFs	within 3ms of the start of the idle state.			
	Reference documents: USB 2.0 Specification, Section 7.1.7.7					
	Results: 101 us					



	⊠ Pass	Fail on Port:		□ N/A
	Comments:			
С.6 Но	ost Test J/K, SE0	_NAK (EL_8, E	CL_9)	
EL_8	When either D+ o	r D- are driven hig	gh, the output volta	ge must be $400 \text{mV} \pm 10\%$ when terminated with
precision	1 45 Ohm resistors to	ground.		
	Reference docume	nts: USB 2.0 Specif	fication, Section 7.1.	1.3
	Port		1	
	Test	D+	D-	
	J (mV)	-	0	
	K (mV)	0	-	
	Overall Results:			
	⊠ Pass	Fail on Port:		□ N/A
	Comments:			
EL_9	When either D+ or	D- are not being of	driven, the output v	oltage must be $0V \pm 10 mV$ when terminated with
precision	1 45 Ohm resistors to	ground.		
	Reference docume	nts: USB 2.0 Specif	fication, Section 7.1.	1.3
	Port		1	
	Test	D+	D-	
	Results (mV)	0	0	
	Overall Results:			
	□ Pass	Fail on Port:		□ N/A
	Comments:			

D. PET Test Results:	Pass Fail
Automated Test Chapter 6	
A-UUT Initial Power-up Test	Pass Fail N/A
A-UUT VBUS Voltage Test	Pass Fail N/A
A-UUT Bypass Capacitance Test	☐ Pass ☐ Fail ☐ N/A
A-UUT SRP Test	☐ Pass ☐ Fail ☐ N/A
A-UUT ADP Test	☐ Pass ☐ Fail ☐ N/A
A-UUT Leakage Test	☐ Pass ☐ Fail ☐ N/A
EH, Capable of ADP and SRP, State Transition Test	☐ Pass ☐ Fail ☐ N/A
EH, Capable of ADP but not SRP, State Transition Test	☐ Pass ☐ Fail ☐ N/A
EH, Capable of SRP but not ADP, State Transition Test	☐ Pass ☐ Fail ☐ N/A
EH with no Session Support State Transition Test	Pass Fail N/A
EH, Capable of ADP/SRP, but not HNP, State Transition Test	☐ Pass ☐ Fail ☐ N/A
EH, Capable of ADP but not SRP/HNP, State Transition Test	☐ Pass ☐ Fail ☐ N/A
EH, Capable of SRP but not ADP/HNP, State Transition Test	☐ Pass ☐ Fail ☐ N/A
EH with no Session/HNP Support State Transition Test	Pass Fail N/A
A-UUT "Device No Response" for connection timeout	Pass Fail N/A
A-UUT "Unsupported Device" Message	Pass Fail N/A
EH using Micro-AB "Incorrect Connection"	☐ Pass ☐ Fail ☐ N/A

E. Interoperability Test Results:	🛛 Pass 🗌 Fail
Manual Test Chapter 7	
A-UUT Functionality B-devices	Pass Fail N/A
A-UUT Category Functionality B-devices	🛛 Pass 🔲 Fail 🔲 N/A
A-UUT Boot test	🛛 Pass 🔲 Fail 🔲 N/A
A-UUT Legacy Speed Test	☐ Pass ☐ Fail ☒ N/A
A-UUT Concurrent and Independently test	☐ Pass ☐ Fail ☐ N/A
A-UUT Unsupported device Message test	Pass Fail N/A
A-UUT Hub Error Message test	Pass Fail N/A
A-UUT Hub Functionality test	☐ Pass ☐ Fail ☒ N/A
A-UUT Hub maximum tier test	☐ Pass ☐ Fail ☒ N/A
A-UUT Hub Concurrent and Independent test	☐ Pass ☐ Fail ☒ N/A
A-UUT Bus powered hub power exceeded test	☐ Pass ☐ Fail ☒ N/A
A-UUT Maximum concurrently device exceed message test	☐ Pass ☐ Fail ☐ N/A
A-UUT Standby test	☐ Pass ☐ Fail ☒ N/A
A-UUT Standby Disconnect test	☐ Pass ☐ Fail ☒ N/A
A-UUT Standby Attach test	☐ Pass ☐ Fail ☒ N/A
A-UUT Standby Topology Change test	Pass Fail N/A
A-UUT Standby Remote Wakeup test	☐ Pass ☐ Fail ☒ N/A
OTG to OTG test	☐ Pass ☐ Fail ☒ N/A

F. Targeted Peripheral List (TPL) Form

F.1 Host Information:

Enter the following information only once.				
Vendor Name:	Microsemi, SOC	Products Group		
Product Name:	Smartfusion2 EH			
Product Model:	DVP-102-000304	-001-RevC		
Product Revision:	<u>1</u>			
SRP Support:	<u>No</u>			
Downstream Ports:	<u>1</u>			
Signaling Speeds Supported:	Low	☐ Full		⊠ High
Supported Transports: Control	Bulk	Interrupt		☐ Isochronous
Messaging Interface: Graphic Screen	een Text Screen	☐ Indicator L	ights	
Max Current Capability:	<u>500</u> mA			
F.2 Targeted Peripherals Information	: Used for Testi	ng		
9 1		8		
Enter the following information for each sur	pported peripheral.			
Vendor Name:	Sandisk			
Product Name:	Cruzer Blade 4GI	3		
Model:	SDCZ50-004G			
Revision:	0			
Vendor ID:	0x781			
Product ID:	0x5567			
Device Class:	MSC			
SRP Support:	☐ Yes	⊠ No		
HNP Support:	☐ Yes	⊠ No		
* Maximum Operation Power (mA):	200 mA	<u> </u>		
† Maximum USB Signaling Speed:	Low	☐ Full	⊠ High	
Waximum OSB Signamig Specu.	☐ Low	run	∠ Ingn	
Vendor Name:	<u>Sandisk</u>			
Product Name:	Cruzer Blade 8GF	3		
Model:	SDCZ50-008G	_		
Revision:	0			
Vendor ID:	<u>0x781</u>			
Product ID:	0x5567			
Device Class:	MSC			

[†] Maximum signaling speed when connected to a high-speed host



Page: 11/13

^{*} Obtained from the bMaxPower field of the device's Standard Configuration Descriptor

SRP Support:	Yes	⊠ No	
HNP Support:	∐ Yes	⊠ No	
‡ Maximum Operation Power (mA):	200 mA	_	_
§ Maximum USB Signaling Speed:	Low	Full	⊠ High
Vendor Name:	<u>Sandisk</u>		
Product Name:	Cruzer Blade 16G	·B	
Model:	SDCZ50-016G	<u>5</u>	
Revision:	<u>0</u>		
Vendor ID:	<u>0</u> x781		
Product ID:	$\frac{0x701}{0x5567}$		
Device Class:	MSC		
SRP Support:	Yes	⊠ No	
HNP Support:	Yes	⊠ No	
** Maximum Operation Power (mA):	200 mA		
†† Maximum USB Signaling Speed:	Low	☐ Full	
Waximum OSD Signaming Speed.	□ Low	run	∐ IIIgii
Vendor Name:	Kingston Technol	igy	
Product Name:	Data Traveler 4Gl	<u>3</u>	
Model:	DTI/4GB		
Revision:	<u>0</u>		
Vendor ID:	<u>0x951</u>		
Product ID:	<u>0x1607</u>		
Device Class:	<u>MSC</u>		
SRP Support:	Yes	No	
HNP Support:	Yes	⊠ No	
‡‡ Maximum Operation Power (mA):	<u>200</u> mA		
§§ Maximum USB Signaling Speed:	☐ Low	☐ Full	
Vendor Name:	Kingston Technol	igy	
Product Name:	Data Traveler 109		
Model:	DT109N/8GB		
Revision:	<u>0</u>		
Vendor ID:	<u>0x930</u>		
	<u>0X930</u>		
Product ID:	$\frac{0x950}{0x6545}$		

^{§§} Maximum signaling speed when connected to a high-speed host



[‡] Obtained from the bMaxPower field of the device's Standard Configuration Descriptor

[§] Maximum signaling speed when connected to a high-speed host

^{**} Obtained from the bMaxPower field of the device's Standard Configuration Descriptor

^{††} Maximum signaling speed when connected to a high-speed host

Obtained from the bMaxPower field of the device's Standard Configuration Descriptor

SRP Support:	☐ Yes	⊠ No	
HNP Support:	☐ Yes	⊠ No	
*** Maximum Operation Power (mA):	<u>200</u> mA		
††† Maximum USB Signaling Speed:	Low	Full	⊠ High
Vendor Name:	Transcend		
Product Name:	Jet Flash 300, 4GE	<u>3</u>	
Model:	TS4GJF30		
Revision:	<u>0</u>		
Vendor ID:	<u>0x8564</u>		
Product ID:	<u>0x1000</u>		
Device Class:	<u>MSC</u>		
SRP Support:	☐ Yes	⊠ No	
HNP Support:	Yes Yes	⊠ No	
** Maximum Operation Power (mA):	<u>100</u> mA		
§§§ Maximum USB Signaling Speed:	Low	Full	⊠ High

- End of document-

^{§§§} Maximum signaling speed when connected to a high-speed host



Page: 13/13

^{***} Obtained from the bMaxPower field of the device's Standard Configuration Descriptor

^{†††} Maximum signaling speed when connected to a high-speed host

Obtained from the bMaxPower field of the device's Standard Configuration Descriptor